

## Absolute Maximum Ratings

$V_{DD}$  to  $V_{SS}$  ..... -0.3V to +72V  
 $GND$  to  $V_{SS}$  ..... -0.3V to  $V_{DD}$   
 $EN, S0, S1, S2$  to  $GND$  .....  
 ..... -0.3V to the lesser of (+12V and  $V_{DD} + 0.3V$ )  
 $IN_-, INA_-, INB_-, OUT, OUTA, OUTB$  to  $V_{SS}$  .....  
 ..... -2V to ( $V_{DD} - V_{SS} + 2V$ ) or 100mA (whichever occurs first)  
 Continuous Current into  $IN_-, INA_-$ ,  
 $INB_-, OUT, OUTA, OUTB$  ..... 100mA  
 Continuous Power Dissipation ( $T_A = +70^\circ C$ )  
 16-Pin TSSOP (derate 11.1mW/ $^\circ C$  above  $+70^\circ C$ ) ..... 890mW

Junction-to-Ambient Thermal Resistance ( $\theta_{JA}$ ) (Note 1)  
 16-Pin TSSOP ..... 90 $^\circ C/W$   
 Junction-to-Case Thermal Resistance ( $\theta_{JC}$ ) (Note 1)  
 16-Pin TSSOP ..... 27 $^\circ C/W$   
 Maximum Operating Temperature Range ..... -40 $^\circ C$  to +125 $^\circ C$   
 Junction Temperature ..... +150 $^\circ C$   
 Storage Temperature Range ..... -65 $^\circ C$  to +150 $^\circ C$   
 Lead Temperature (soldering, 10s) ..... +300 $^\circ C$   
 Soldering Temperature (reflow) ..... +260 $^\circ C$

**Note 1:** Package thermal resistances were obtained using the method described in JEDEC specification JESD51-7, using a four-layer board. For detailed information on package thermal considerations, refer to [www.maximintegrated.com/thermal-tutorial](http://www.maximintegrated.com/thermal-tutorial).

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

## DC Electrical Characteristics—Dual Supplies

( $V_{DD} = +35V$ ,  $V_{SS} = -35V$ ,  $V_{GND} = 0V$ ,  $V_{EN} = +3.3V$ ,  $T_A = -40^\circ C$  to  $+85^\circ C$ , unless otherwise noted. Typical values are at  $T_A = +25^\circ C$ .)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
POWER SUPPLY						
VDD Supply Voltage Range	VDD		+10		+36	V
VSS Supply Voltage Range	VSS		-10		-36	V
VDD Supply Current	IDD(OFF)	VEN = VS_ = 0V, VIN_ = VINA_ = VINB_ = +20V		12	25	μA
	IDD(ON)	VEN = +5V, VS_ = 0V or VEN, VIN_ = VINA_ = VINB_ = +20V		270	600	
VSS Supply Current	ISS(OFF)	VEN = VS_ = 0V, VIN_ = VINA_ = VINB_ = +20V		11	25	μA
	ISS(ON)	VEN = +5V, VS_ = 0V or VEN, VIN_ = VINA_ = VINB_ = +20V		260	600	
ANALOG MUX						
Analog Signal Range	VIN_, VINA_, VINB_, VOUT, VOUTA, VOUTB		VSS		VDD	V
Current Through Multiplexer	IIN_, IINA_, IINB_	VIN_, VINA_, VINB_ = ±20V	-5		+5	mA
On-Resistance	RON	IIN_, IINA_, IINB_ = 5mA; VIN_, VINA_, VINB_, VOUT, VOUTA, VOUTB = ±20V, Figure 1		60	130	Ω
On-Resistance Matching Between Channels	ΔRON	IIN_, IINA_, IINB_ = 5mA, VIN_, VINA_, VINB_ = ±20V, 0V		0.5		Ω
On-Resistance Flatness	RFLAT_(ON)	IIN_, IINA_, IINB_ = 5mA, VIN_, VINA_, VINB_, VOUT, VOUTA, VOUTB = ±20V		0.03		Ω
Output On-Leakage Current	IOUT(ON)	MAX14752: VOUT, VOUTA, VOUTB = ±20V, VIN_, VINA_, VINB_ = unconnected, Figure 2	-20		+20	nA
		MAX14753: VOUT, VOUTA, VOUTB = ±20V, VIN_, VINA_, VINB_ = unconnected, Figure 2	-10		+10	

**DC Electrical Characteristics—Dual Supplies (continued)**(V<sub>DD</sub> = +35V, V<sub>SS</sub> = -35V, V<sub>GND</sub> = 0V, V<sub>EN</sub> = +3.3V, T<sub>A</sub> = -40°C to +85°C, unless otherwise noted. Typical values are at T<sub>A</sub> = +25°C.)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
Output Off-Leakage Current	I <sub>OUT(OFF)</sub>	MAX14752: V <sub>OUT</sub> , V <sub>OUTA</sub> , V <sub>OUTB</sub> = ±20V, V <sub>IN_</sub> , V <sub>INA_</sub> , V <sub>INB_</sub> = -20V, Figure 3	-20		+20	nA
		MAX14753: V <sub>OUT</sub> , V <sub>OUTA</sub> , V <sub>OUTB</sub> = ±40V, V <sub>IN_</sub> , V <sub>INA_</sub> , V <sub>INB_</sub> = -40V, Figure 3	-10		+10	
Input Off-Leakage Current	I <sub>IN(OFF)</sub>	V <sub>OUT</sub> , V <sub>OUTA</sub> , V <sub>OUTB</sub> = ±20V, V <sub>IN_</sub> , V <sub>INA_</sub> , V <sub>INB_</sub> = ±20V, Figure 3	-5		+5	nA
<b>LOGIC (EN, S0, S1, S2)</b>						
EN Input Voltage Low	V <sub>EN_IL</sub>				0.8	V
EN Input Voltage High	V <sub>EN_IH</sub>		2.1			V
EN, S_ Input Voltage Range	V <sub>EN</sub> , V <sub>S_</sub>				11	V
EN Input Current	I <sub>EN_IH(DC)</sub>	V <sub>EN</sub> = +11V, V <sub>S0</sub> = V <sub>S1</sub> = V <sub>S2</sub> = (0.25 × V <sub>EN</sub> ) or (0.75 × V <sub>EN</sub> )			0.4	mA
S0, S1, S2 Input Voltage Low	V <sub>IL</sub>				0.25 × V <sub>EN</sub>	V
S0, S1, S2 Input Voltage High	V <sub>IH</sub>		0.75 × V <sub>EN</sub>			V
<b>DYNAMIC CHARACTERISTICS</b>						
Enable Turn-On Time	t <sub>ON</sub>	V <sub>IN0</sub> , V <sub>INA0</sub> = ±10V, R <sub>L</sub> = 10kΩ, Figure 4		1	25	μs
Enable Turn-Off Time	t <sub>OFF</sub>	V <sub>IN0</sub> , V <sub>INA0</sub> = ±10V, R <sub>L</sub> = 10kΩ, Figure 4		0.8	2	μs
Transition Time	t <sub>TRANS</sub>	V <sub>IN0</sub> , V <sub>INA0</sub> = ±10V, R <sub>L</sub> = 10kΩ, Figure 5		10		μs
Break-Before-Make Time Delay	t <sub>BBM</sub>	V <sub>IN_</sub> , V <sub>INA_</sub> , V <sub>INB_</sub> = ±10V, R <sub>L</sub> = 10kΩ, Figure 6		10		μs
Frequency Response	BW	R <sub>S</sub> = 50Ω, R <sub>L</sub> = 1kΩ, Figure 7			20	MHz
Off-Isolation	V <sub>ISO</sub>	V <sub>IN_</sub> , V <sub>INA_</sub> , V <sub>INB_</sub> = 1V <sub>RMS</sub> , f = 100kHz, R <sub>L</sub> = 50Ω, C <sub>L</sub> = 15pF, Figure 8		65		dB
Crosstalk	V <sub>CT</sub>	R <sub>S</sub> = R <sub>L</sub> = 50Ω, Figure 9		62		dB
Total Harmonic Distortion Plus Noise	THD+N	R <sub>S</sub> = R <sub>L</sub> = 1kΩ, f = 20Hz to 20kHz		0.0014		%
Charge Injection	Q	V <sub>IN_</sub> , V <sub>INA_</sub> , V <sub>INB_</sub> = GND, C <sub>L</sub> = 1nF, Figure 10		200		pC

**DC Electrical Characteristics—Single Supply**(V<sub>DD</sub> = +70V, V<sub>SS</sub> = V<sub>GND</sub> = 0V, V<sub>EN</sub> = +3.3V, T<sub>A</sub> = -40°C to +85°C, unless otherwise noted. Typical values are at T<sub>A</sub> = +25°C.) (Note 2)

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNITS
On-Resistance	R <sub>ON</sub>	I <sub>IN_</sub> = 5mA, V <sub>IN_</sub> , V <sub>OUT</sub> = +20V (MAX14752), V <sub>INA_</sub> , V <sub>OUTA</sub> , V <sub>INB_</sub> , V <sub>OUTB</sub> = +20V (MAX14753), Figure 1		60	130	
OUT, OUTA, OUTB Off-Leakage Current	I <sub>OUT(OFF)</sub> , I <sub>OUTA(OFF)</sub> , I <sub>OUTB(OFF)</sub>	MAX14752: V <sub>OUT</sub> = +40V, V <sub>IN_</sub> = V <sub>INA_</sub> = V <sub>INB_</sub> = +10V, Figure 3	20		+20	nA
		MAX14753: V <sub>OUT</sub> = +40V, V <sub>IN_</sub> = V <sub>INA_</sub> = V <sub>INB_</sub> = +10V, Figure 3	-10		+10	
On-Input Capacitance	C <sub>IN_ON</sub>	MAX14752, V <sub>DD</sub> = +50V, OUT unconnected	V <sub>IN_</sub> = 4V	43		pF
			V <sub>IN_</sub> = 25V	26		
		MAX14753, V <sub>DD</sub> = +50V, OUTA, OUTB unconnected	V <sub>INA_</sub> , V <sub>INB_</sub> = 4V	26		
			V <sub>INA_</sub> , V <sub>INB_</sub> = 25V	16		
Off-Input Capacitance	C <sub>IN_OFF</sub>	MAX14752, V <sub>DD</sub> = +50V	V <sub>IN_</sub> = 4V	6		pF
			V <sub>IN_</sub> = 25V	3.7		
		MAX14753, V <sub>DD</sub> = +50V	V <sub>INA_</sub> , V <sub>INB_</sub> = 4V	6		
			V <sub>INA_</sub> , V <sub>INB_</sub> = 25V	3.7		
Off-Output Capacitance	C <sub>OUT_OFF</sub>	MAX14752, V <sub>DD</sub> = +50V	V <sub>OUT_</sub> = 4V	35		pF
			V <sub>OUT_</sub> = 25V	20		
		MAX14753, V <sub>DD</sub> = +50V	V <sub>OUTA_</sub> , V <sub>OUTB_</sub> = 4V	19		
			V <sub>OUTA_</sub> , V <sub>OUTB_</sub> = 25V	11		

**Note 2:** All parameters in single-supply operation are expected to be the same as in dual-supplies operation.**Note 3:** IN-OUT capacitances are negligible (< 1pF).

Test Circuits/Timing Diagrams/Truth Tables

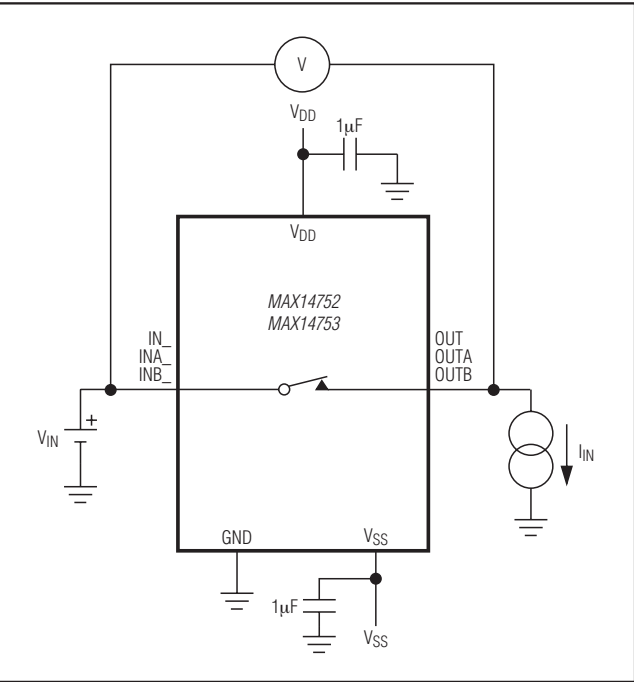


Figure 1. On-Resistance

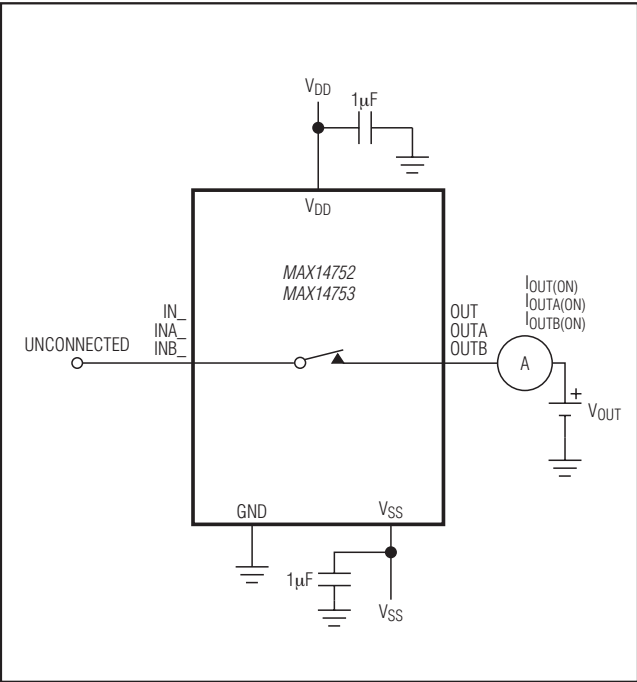


Figure 2. On-Leakage Current

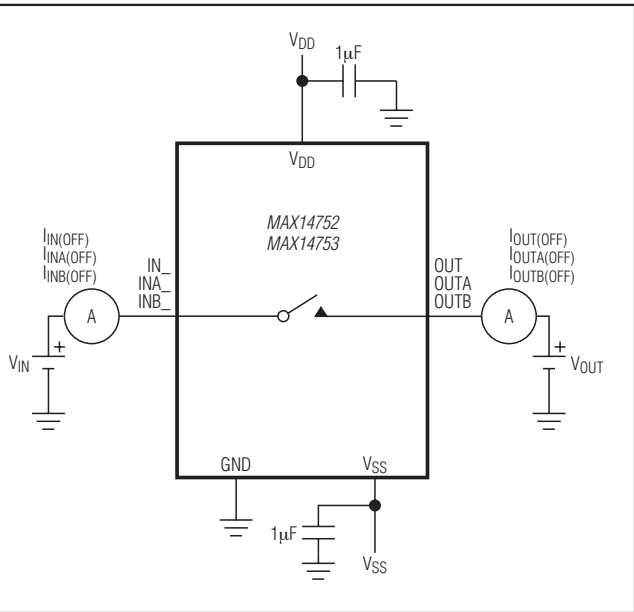


Figure 3. Off-Leakage Current

Test Circuits/Timing Diagrams/Truth Tables (continued)

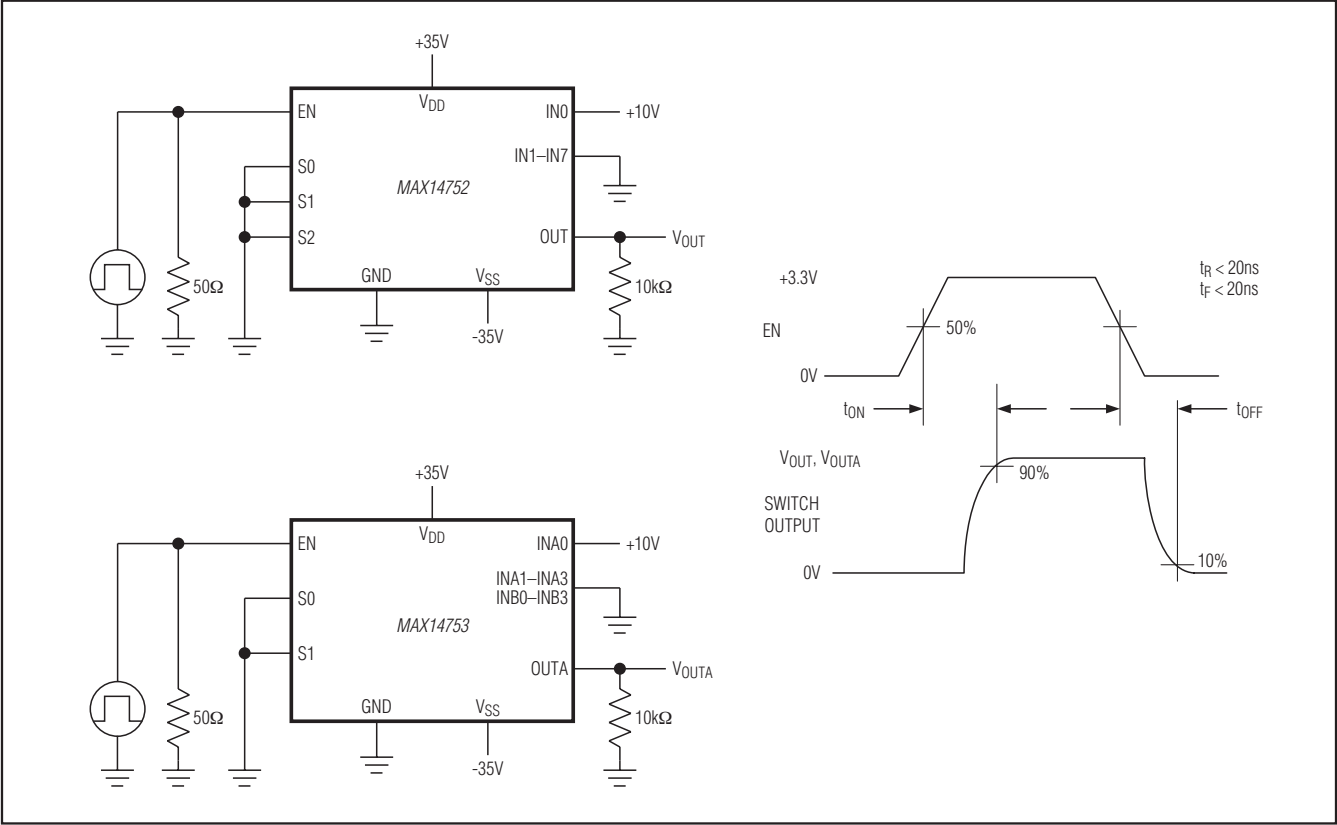


Figure 4. Enable Switching Time

## Test Circuits/Timing Diagrams/Truth Tables (continued)

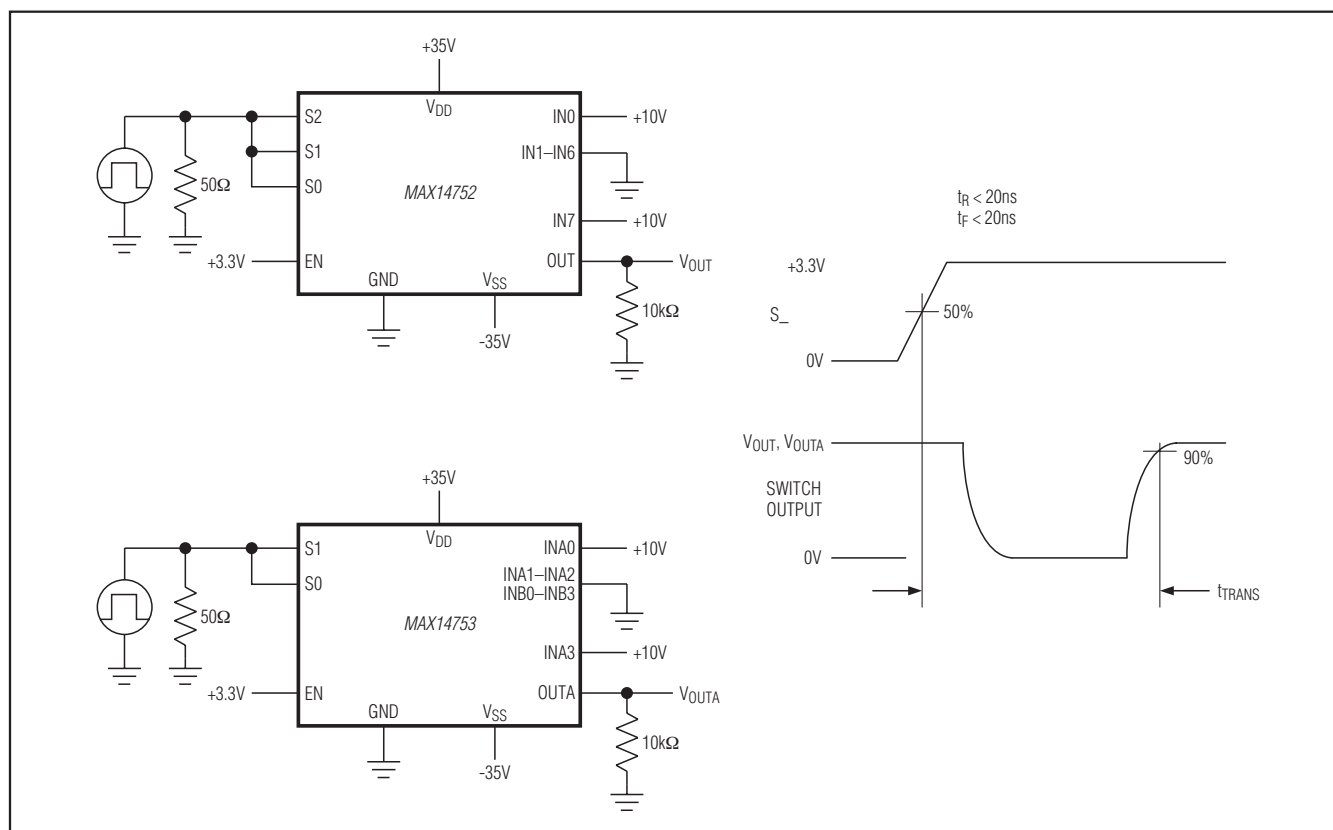


Figure 5. Transition Time

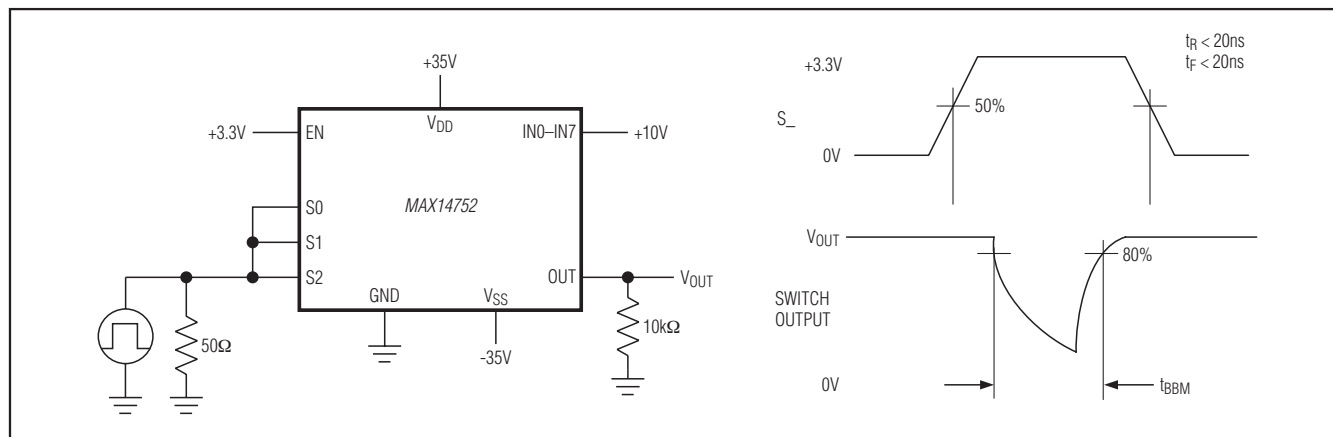


Figure 6. Break-Before-Make Interval

Test Circuits/Timing Diagrams/Truth Tables (continued)

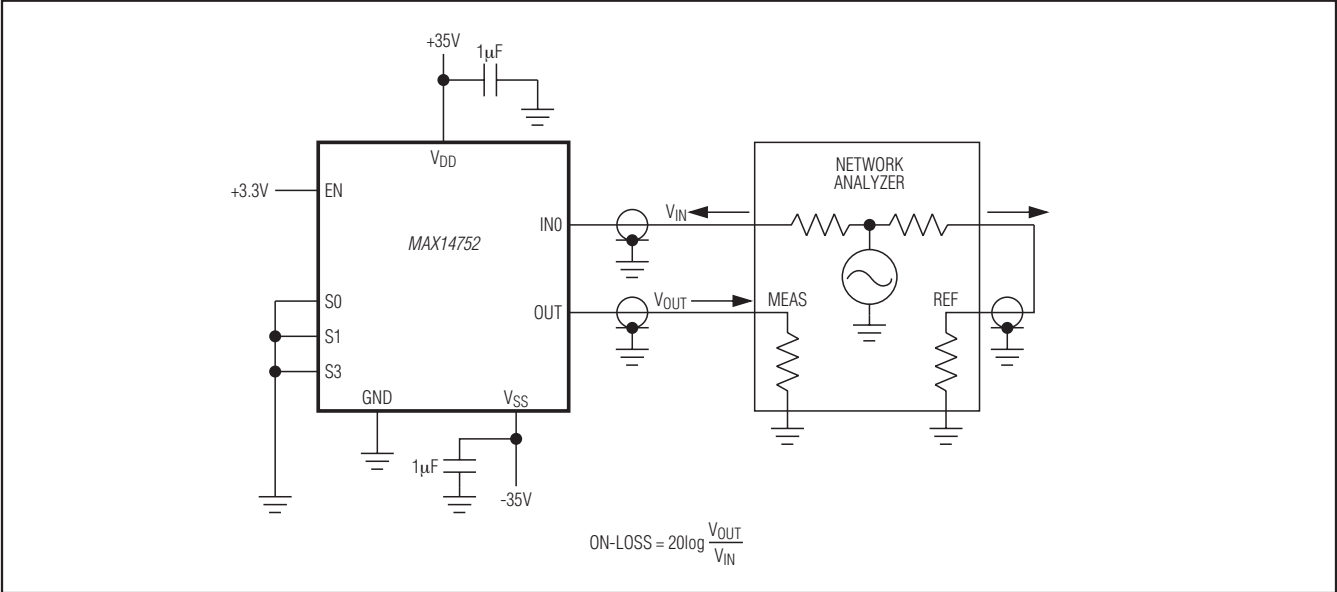


Figure 7. Frequency Response

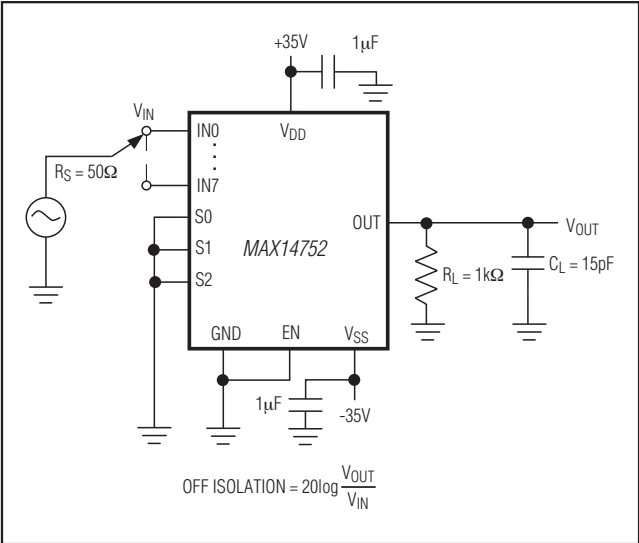


Figure 8. Off-Isolation

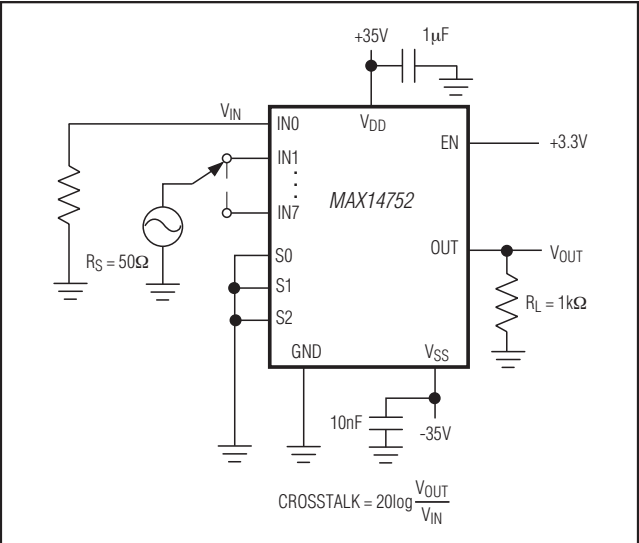


Figure 9. Crosstalk

Test Circuits/Timing Diagrams/Truth Tables (continued)

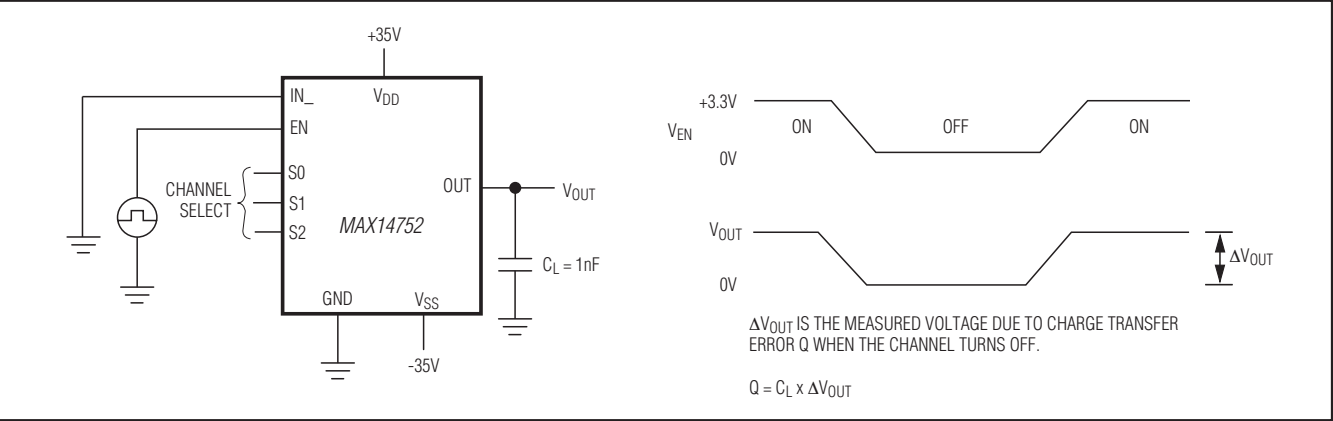


Figure 10. Charge Injection

Table 1. MAX14752 Truth Table

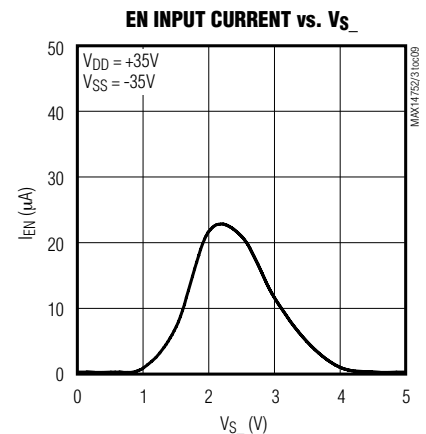
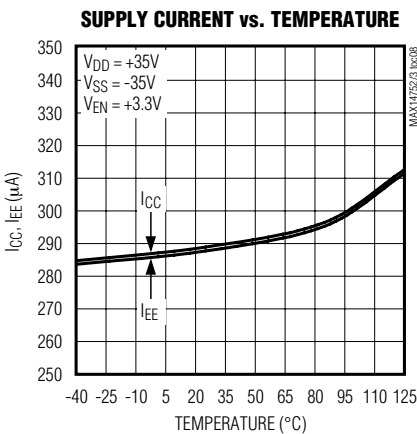
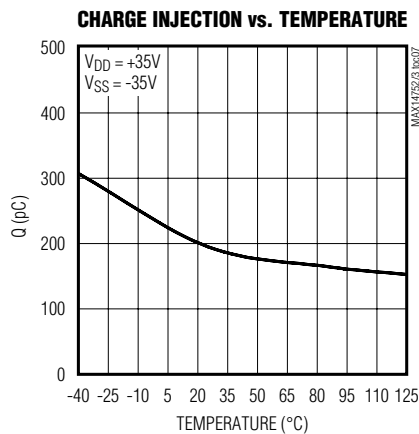
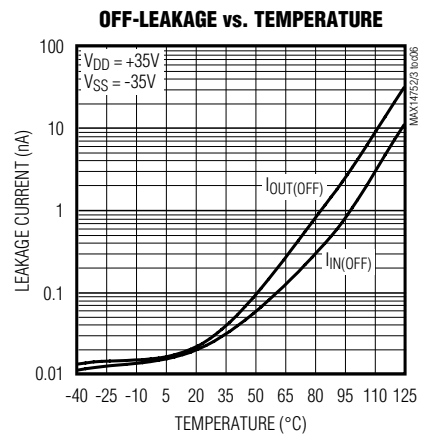
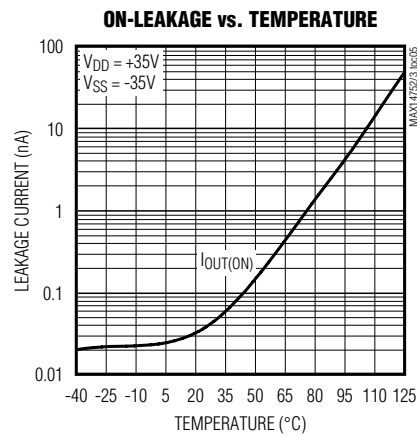
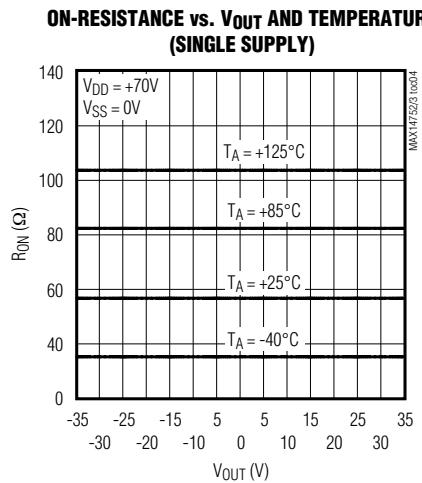
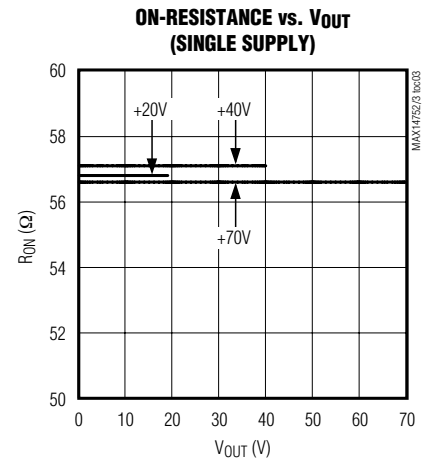
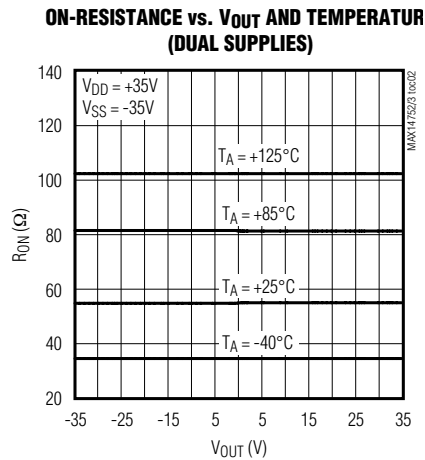
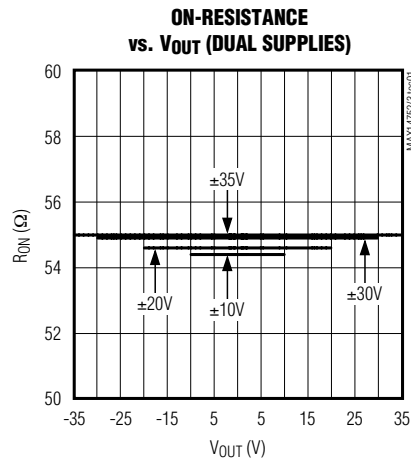
S2	S1	S0	EN	OUT
X	X	X	0	All off
0	0	0	1	IN0
0	0	1	1	IN1
0	1	0	1	IN2
0	1	1	1	IN3
1	0	0	1	IN4
1	0	1	1	IN5
1	1	0	1	IN6
1	1	1	1	IN7

Table 2. MAX14753 Truth Table

S1	S0	EN	OUTA	OUTB
X	X	0	All off	All off
0	0	1	INA0	INB0
0	1	1	INA1	INB1
1	0	1	INA2	INB2
1	1	1	INA3	INB3

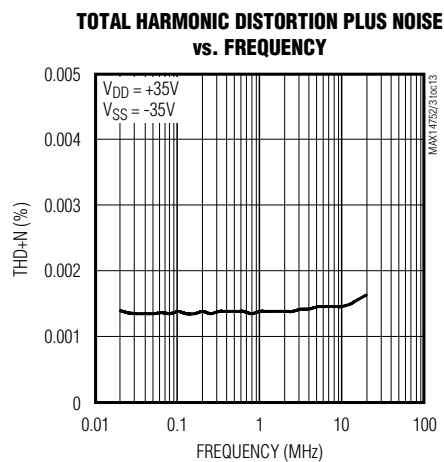
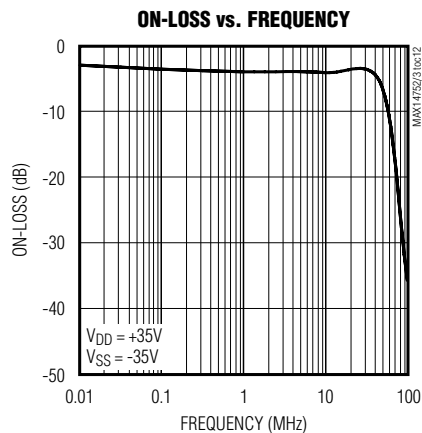
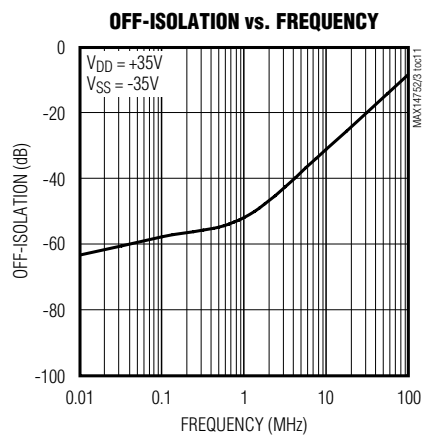
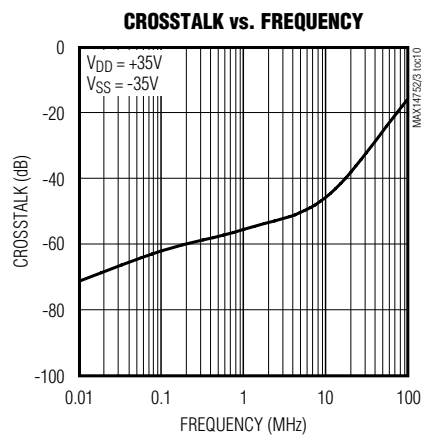


## Typical Operating Characteristics

(T<sub>A</sub> = +25°C, unless otherwise noted.)

## Typical Operating Characteristics (continued)

( $T_A = +25^\circ\text{C}$ , unless otherwise noted.)



**MAX14752 Pin Description (Single 8-to-1 Mux)**

PIN	NAME	FUNCTION
1	S0	Mux Input Select
2	EN	Mux Enable. Drive EN high to enable the device. The EN high voltage defines input logic voltage level for S0, S1, and S2.
3	VSS	Negative Supply Voltage. Bypass VSS to GND with a 1μF ceramic capacitor.
4	IN0	Bidirectional Analog Input
5	IN1	Bidirectional Analog Input
6	IN2	Bidirectional Analog Input
7	IN3	Bidirectional Analog Input
8	OUT	Bidirectional Analog Output
9	IN7	Bidirectional Analog Input
10	IN6	Bidirectional Analog Input
11	IN5	Bidirectional Analog Input
12	IN4	Bidirectional Analog Input
13	VDD	Positive Supply Voltage. Bypass VDD to GND with a 1μF ceramic capacitor.
14	GND	Ground. Connect GND to VSS for single supply. Bypass GND to VSS with a 1μF ceramic capacitor for dual supply.
15	S2	Mux Input Select
16	S1	Mux Input Select

**MAX14753 Pin Description (Dual 4-to-1 Mux)**

PIN	NAME	FUNCTION
1	S0	Mux Input Select
2	EN	Mux Enable. Drive EN high to enable the device. The EN high voltage defines input logic voltage level for S0 and S1.
3	VSS	Negative Supply Voltage. Bypass VSS to GND with a 1μF ceramic capacitor.
4	INA0	Bidirectional Analog Input
5	INA1	Bidirectional Analog Input
6	INA2	Bidirectional Analog Input
7	INA3	Bidirectional Analog Input
8	OUTA	Bidirectional Analog Output
9	OUTB	Bidirectional Analog Output
10	INB3	Bidirectional Analog Input
11	INB2	Bidirectional Analog Input
12	INB1	Bidirectional Analog Input
13	INB0	Bidirectional Analog Input
14	VDD	Positive Supply Voltage. Bypass VDD to GND with a 1μF ceramic capacitor.
15	GND	Ground. Connect GND to VSS for single supply. Bypass GND to VSS with a 1μF ceramic capacitor for dual supply.
16	S1	Mux Input Select

## Detailed Description

The MAX14752/MAX14753 are 8-to-1 and dual 4-to-1 high-voltage analog multiplexers. Both devices feature 60Ω (typ) on-resistance with 0.03Ω (typ) on-resistance flatness. These low on-resistance multiplexers conduct equally well in either direction.

The MAX14752 is an 8-to-1 multiplexer and MAX14753 is a dual 4-to-1 multiplexer. Both devices operate with dual supplies of ±10V to ±36V or a single supply of +20V to +72V. Both devices can also operate with unbalanced supplies, such as +36V and -10V. These multiplexers support rail-to-rail input and output signals. The control logic level is defined via the EN input. These devices do not require power-supply sequencing.

## Applications Information

### Current Through the Mux

The current flowing through each on-channel of the MAX14752/MAX14753 multiplexers must be limited to ±5mA for normal operation. If the current exceeds this limit, an internal leakage current from that channel to V<sub>SS</sub> appears. Larger input current does not destroy the device if the max power dissipation is not exceeded.

### Input Voltage Clamping

For applications that require input voltages beyond the normal operating voltages, the internal input diodes to V<sub>DD</sub> and V<sub>SS</sub> can be used to limit the input voltages. As shown in Figure 11, series resistors can be employed at the inputs to limit the currents flowing into the diodes during undervoltage and overvoltage conditions. Choose the

limiting resistors such that the input currents are limited to I<sub>IN(max)</sub> = 100mA. The values of the current limit resistors can be calculated as the larger of R<sub>LIM+</sub> and R<sub>LIM-</sub>.

$$R_{LIM+} = \frac{V_{IN(max)} - V_{DD}}{I_{IN(max)}}$$

$$R_{LIM-} = \frac{V_{SS} - V_{IN(min)}}{I_{IN(max)}}$$

During an undervoltage or overvoltage condition, the input impedance is equal to R<sub>LIM</sub>. The additional power dissipation due to the fault currents needs to be calculated. The MAX14752/MAX14753 multiplexer operates normally on a channel that is on during an overvoltage or undervoltage clamping condition on a second channel that is not switched.

### Beyond-the-Rail Input

If input voltages are expected to go beyond the supply voltages, but within the absolute maximum supply voltages of the MAX14752/MAX14753, add two diodes in series with the supplies as shown in Figure 12.

During undervoltage and overvoltage events, the internal diodes pull V<sub>DD</sub>/V<sub>SS</sub> supplies up/down. An advantage of this scheme is that the input impedance is high and currents do not flow through the MAX14752/MAX14753 during overvoltage and undervoltage events. The input voltages must be limited to the voltages specified in the *Absolute Maximum Ratings* section.

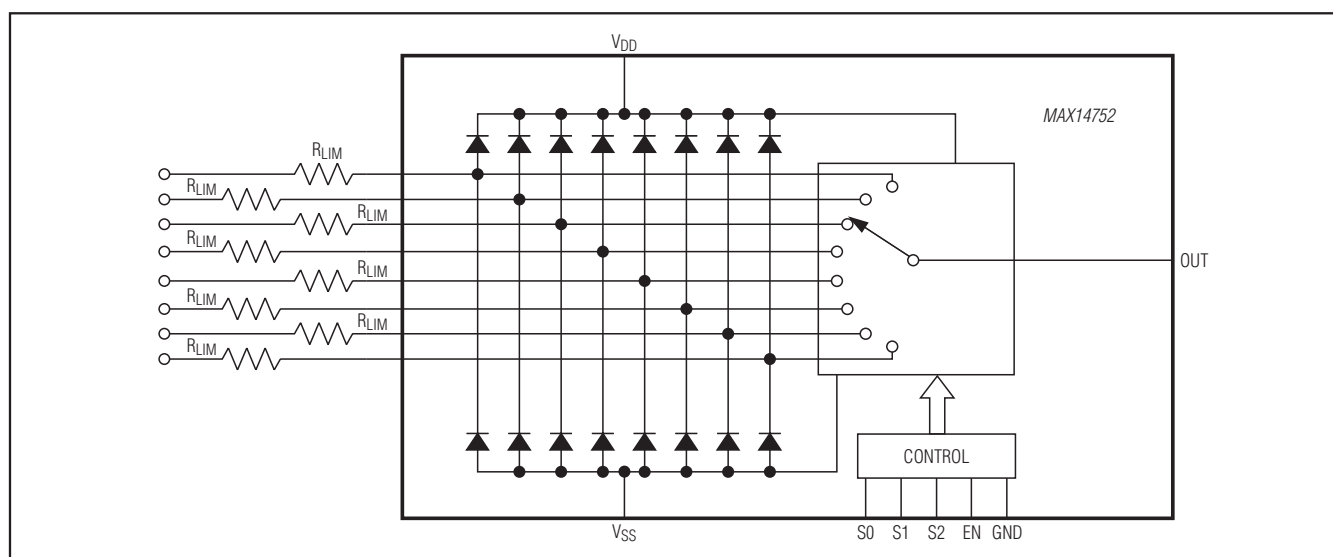


Figure 11. Input Overvoltage and Undervoltage Clamping

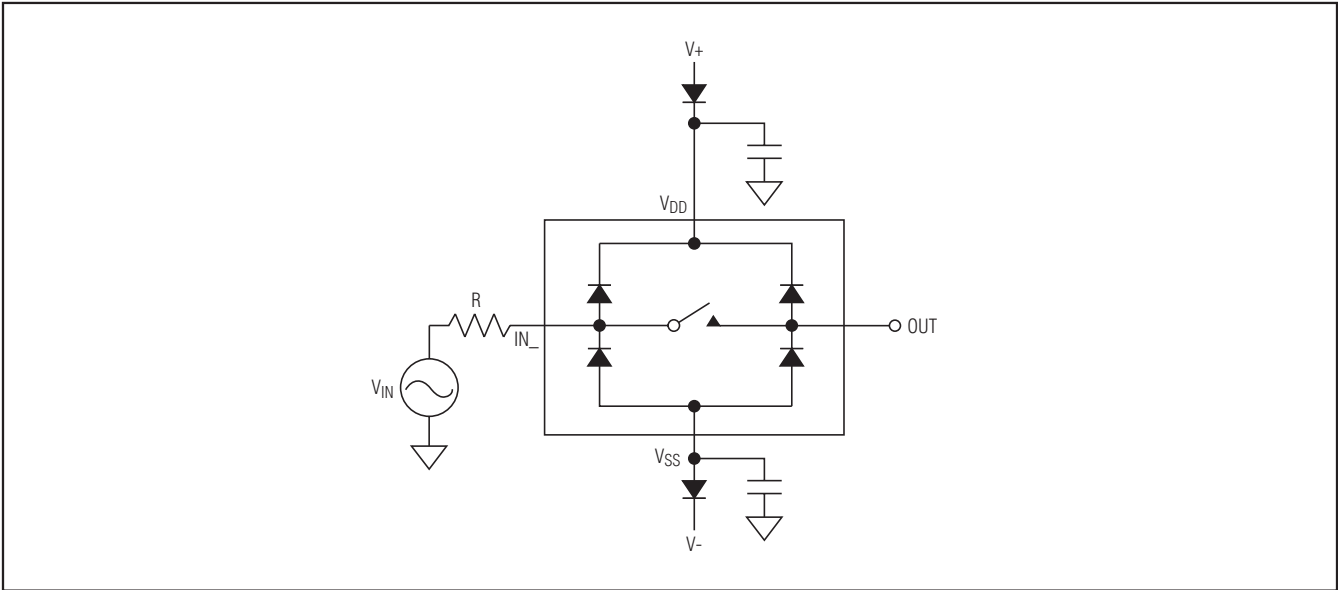
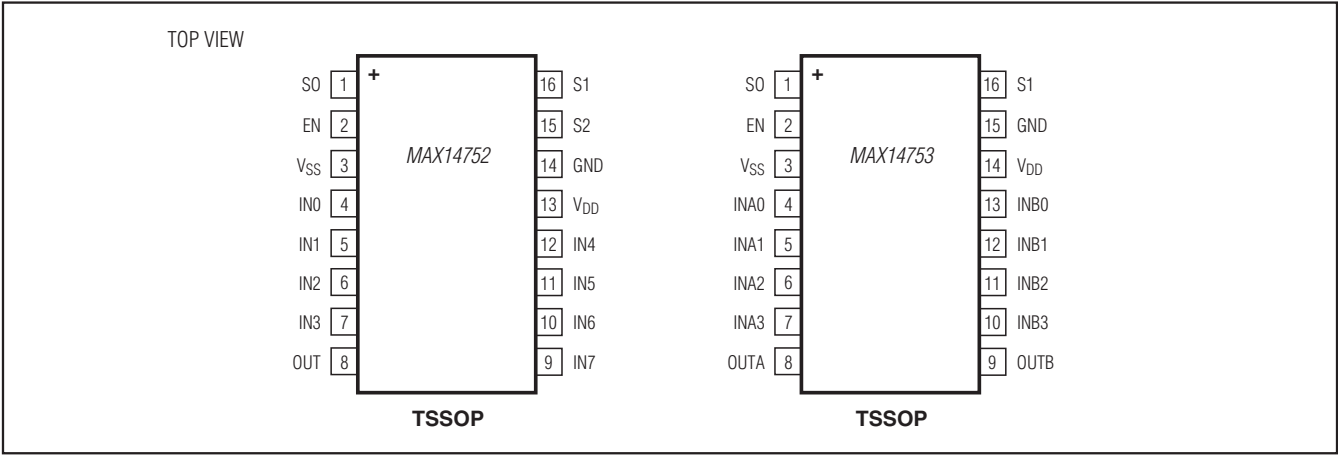


Figure 12. Beyond-the-Rail Application

Pin Configurations



Chip Information

PROCESS: CMOS

Package Information

For the latest package outline information and land patterns (footprints), go to [www.maximintegrated.com/packages](http://www.maximintegrated.com/packages). Note that a “+”, “#”, or “-” in the package code indicates RoHS status only. Package drawings may show a different suffix character, but the drawing pertains to the package regardless of RoHS status.

PACKAGE TYPE	PACKAGE CODE	OUTLINE NO.	LAND PATTERN NO.
16 TSSOP	U16+1	<a href="#">21-0066</a>	<a href="#">90-0117</a>

## Revision History

REVISION NUMBER	REVISION DATE	DESCRIPTION	PAGES CHANGED
0	8/08	Initial release	—
1	10/08	Changed the units from mA to $\mu$ A for $V_{DD}$ and $V_{SS}$ supply current in the <i>DC Electrical Characteristics—Dual Supplies</i> table	2
2	2/09	Added capacitance information to EC table	2, 4, 13, 14, 15, 16
3	7/10	Deleted the “Input Capacitance” parameter from the <i>DC Electrical Characteristics—Dual Supplies</i>	3
4	4/15	Removed automotive reference	1
5	5/15	Revised <i>Benefits and Features</i> section	1

For pricing, delivery, and ordering information, please contact Maxim Direct at 1-888-629-4642, or visit Maxim Integrated's website at [www.maximintegrated.com](http://www.maximintegrated.com).

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